

Systematic Operating Temperature Differences Between Al-BSF, PERC, and PERT-With-Optimized-Rear-Reflector Solar Mini-Modules Due to Rear Reflectance

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Abstract—Reflecting sub-bandgap light from photovoltaic modules has the potential to improve lifetime energy generation of fielded systems by reducing operating temperature. In this article, the temperature of fielded aluminum back-surface field (Al-BSF) and passivated emitter and rear contact (PERC) mini-modules was monitored every 5 minutes for 75 days along with corresponding meteorological data. Additionally, passivated emitter rear totally diffused (PERT) mini-modules with high-performance sub-bandgap rear reflectors were tested and compared to the state-of-the-art industrial modules. These reflectors consisted of a >300-nm-thick silicon dioxide nanoparticle film with a low refractive index. The impact of reflectance on measured operating temperature was isolated with a previously developed thermal model and quantified as the reflectance-induced median temperature difference between each tested module at representative outdoor conditions (1000 W·m⁻², 25°C ambient temperature, and 1.43 m·s⁻¹ wind speed). We found that, because of their reflectance differences, PERC modules ran systematically cooler than Al-BSF modules by 1.0°C, whereas the PERT-with-optimized-rear-reflector systematically operated 1.4°C cooler than the Al-BSF module and 0.4°C than the PERC module. We also found that the rear reflector provided the greatest temperature benefit during periods of highest irradiance.

Index Terms—Optics, photovoltaic cells, photovoltaic systems, solar panels, thermal management.

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I. INTRODUCTION

PHOTOVOLTAIC (PV) cells are typically characterized at standard test conditions (STC) of 25°C and AM1.5G irradiance. When installed in the field, however, cells are encapsulated in module materials and operate at meteorological and irradiance conditions different than STC [1], [2]. This leads to operating temperatures higher than 25°C, and even exceeding 70°C in some cases [3], [4]. The waste heat generated in the module has a large impact on the energy yield of an outdoor system. The power output of the module decreases as its operating temperature increases; this loss is commonly described by a temperature coefficient [5]. For commercial silicon PV technology, the temperature coefficient of efficiency ranges from approximately $-0.38\%/^{\circ}\text{C}$ for high-quality monocrystalline passivated emitter rear totally diffused (PERT) to $-0.4\%/^{\circ}\text{C}$ for passivated emitter and rear contact (PERC) modules to $-0.43\%/^{\circ}\text{C}$ for traditional aluminum back-surface field modules (Al-BSF) [6]. Higher module temperature not only reduces instantaneous operating efficiency but also accelerates nearly every type of module degradation [7]. For instance, rates of encapsulant browning were higher during accelerated testing of field-aged silicon modules when they were held at 85°C compared to 60°C; this resulted in a relative short-circuit current (I_{sc}) drop of 3.26% for the warmer module and 1.37% for the cooler one [8]. Thus, reducing operating temperature in the field results in higher power conversion efficiency and longer system lifetime, manifesting as lower levelized cost of electricity and greater value for the end user [9]. As a result, a broad range of thermal mitigation strategies has been investigated [10].

The waste heat in the module originates from two sources: losses in the process of converting radiative energy to electrical energy (thermalization, nonradiative recombination, transport, Carnot, etc.) and parasitic absorption of light in the module that does not lead to electrical energy generation [11]. The former are fundamental limitations in the PV energy conversion process and minimizing their degree through efficiency enhancement has long been the focus of PV research; the single-junction silicon efficiency record is currently 26.7%, just short of the approximate 29% intrinsic limit [12]. A particularly insidious form of the latter heating mechanism is the parasitic absorption of light that

does not contain sufficient energy to create electron–hole pairs in the absorber, known as sub-bandgap radiation. In the case of silicon, with a bandgap of 1.12 eV, approximately 19% of incident solar radiation is sub-bandgap [13]. Thermal modifications focusing on sub-bandgap radiation present a particularly attractive opportunity to reduce PV module operating temperature since the source of heat is both large and fundamentally avoidable in the energy conversion process. Indeed, multiple studies have found increasing sub-bandgap reflection to be among the most worthwhile thermal management approaches [14]–[16].

The ideal implementation of this thermal management strategy would result in 100% reflectance of sub-bandgap light. Silverman *et al.* [14] modeled this idealized structure and calculated a 3.8 °C difference in annual irradiance-weighted temperature between a standard Al-BSF module and one with such an ideal sub-bandgap reflector. For a module with a temperature coefficient of $-0.4\%/^{\circ}\text{C}$, a 3.8 °C temperature decrease results in a 1.52% absolute gain in efficiency. In Silverman’s work, the ideal sub-bandgap reflector operated on the front side of the module. Slauch *et al.* [17] further developed this approach to show how reflector designs at the front air/glass interface can impact thermal and energy benefits in real-world conditions. In simulations, a 13-layer sub-bandgap mirror and 20-layer mirror on the outer air/glass interface increased reflectance at the peak sub-bandgap wavelength by 52% and 73%, respectively, and reduced parasitic absorption in the silicon module by 41 and 51 $\text{W}\cdot\text{m}^{-2}$, respectively. Each of these mirror designs increased calculated annual energy yield by at least 3.6% compared to a baseline module through a combination of higher transmittance of super-bandgap light (optical benefit) and higher reflectance of sub-bandgap light (thermal benefit) [18]. These energy benefit calculations are before accounting for accelerated module degradation associated with higher operating temperature of modules without optimized sub-bandgap reflectors.

Double-layer stacks provide an easier and less expensive route to implementation; simulated double-layer stacks of $\text{MgF}_2/\text{Al}_2\text{O}_3$ produced approximately 0.8% annual energy yield increase relative to standard module glass anti-reflection coatings [19]. While front-side reflectors can minimize parasitic absorption in the front module materials, a drawback of front-side reflectors is the additional constraint of effective transmission of light above the bandgap and a requirement for durable materials that can maintain their properties while exposed to the ambient for decades. More recent calculations by Slauch *et al.* [20] found that an optimized reflector at the interface between the front encapsulant and the cell reduces annual power-weighted average operating temperature under realistic power-generating conditions by up to 2.2 °C for Al-BSF modules and 1.8 °C for PERC modules, respectively.

An alternative location for a sub-bandgap reflector is the rear side of the solar cell. Inserting dielectric/metal stacks on the rear side of a silicon wafer can drastically increase reflectance. For instance, $\text{SiN}_x/\text{Si}/\text{MgF}_2/\text{Ag}$ test structures exhibited sub-bandgap reflectance over 90% and average per-bounce internal reflectance greater than 99.5% [21]. With these structures, Holman *et al.* showed that parasitic absorption in the metal is

primarily caused by the evanescent field of high-incidence-angle p-polarized light reaching the metal surface, thereby exciting surface plasmon polaritons [22]. The thickness and the refractive index of the dielectric interlayer strongly affect the penetration depth of the electric field, and they can thereby be tuned to maximize reflectance. Further studies investigating the influence of surface texturing, dielectric refractive index, and metal composition have yielded some general design rules to optimize rear reflectance: the dielectric thickness should be at least 200 nm and its refractive index should be as low as possible [23]. While engineering the sub-bandgap reflector to be on the rear side leaves the cell prone to parasitic absorption by the layers at the front of the module and cell, it nonetheless has significant potential for module temperature reduction because of the outsized role that the rear metal plays. Slauch *et al.* [20] found that increasing internal reflection at the rear surface of an Al-BSF cell from 67% to 100% can provide up to 1.2 °C annual average temperature decrease and up to 2.8 °C cooling under one-sun conditions.

Metal electrodes directly on the rear of silicon wafers—particularly those formed from pastes—can absorb the majority of longer wavelength light that does not get absorbed in the wafer, as exhibited in Al-BSF cells. High-temperature firing of the printed Al paste forms Al+Si interface regions between the silicon wafer and pure Al electrode due to interdiffusion and alloying of Al and Si [24]. Optical modeling of silicon modules by Subedi *et al.* [24] showed over a 20% difference absolute in reflectance at 1200 nm between Si/Al structures with and without the Al+Si interfacial region. The same highly absorptive Al+Si region also exists in PERC devices, though minimizing its volume is the core design principle behind PERC. In addition to the total contacted area, the 3-D geometry of the cell’s contact region affects sub-bandgap optics, as the Al+Si region diffuses vertically from the contact opening into the Si wafer and also laterally into the absorber regions adjacent to the contact openings. Detailed models have recently been developed to simulate reflectance for Al-BSF cells and PERC cells with contact geometries consisting of lines or dashes. These results showed reflectances, R , at 1200 nm of 15.9%, 23.1%, and 28.1%, respectively, highlighting the optical benefit of the rear dielectric passivation stack of PERC [25].

As emphasized previously, this optical benefit can translate to a thermal benefit. Under computer-simulated AM1.5G irradiation, Vogt *et al.* showed that modeled PERC structures operated 1.7 °C cooler than Al-BSF, 0.8 °C of which was due to higher efficiency (1.9% absolute in this study), and 0.9 °C of which was attributable to lower parasitic absorption in the rear metal electrode [26]. The reflected portion of the AM1.5G spectrum was 126.3 and 143.2 $\text{W}\cdot\text{m}^{-2}$ for Al-BSF and PERC, respectively. Though there is evidence to suggest the superior sub-bandgap reflectance of PERC would yield a temperature benefit in real outdoor operating conditions, this has not yet been demonstrated, to the authors’ knowledge. Tests on fielded modules are an important step to validate thermal benefits of new materials and predict consequential energy production benefits, as spectral and angle-of-incidence variation

184 affect module optics [3], [18]. Furthermore, while the dielectric
 185 passivation in the PERC cell has an appreciable impact on
 186 reflectance, and consequently on temperature, the reflectance
 187 is still far from the possible reflectance of 90% demonstrated
 188 by Holman *et al.* [21]. Thus, there is a large opportunity to
 189 lower module operating temperature by implementing ideal
 190 rear dielectric layers into industrially manufactured silicon PV
 191 cells.

192 In this article, we test this thermal management approach by
 193 including an optimized sub-bandgap reflector in PERT solar
 194 cells. These cells are fabricated into mini-modules that are
 195 deployed outdoors for testing. The dielectric layer introduced is a
 196 porous SiO_2 nanoparticle (NP) coating with optimized thickness
 197 and low refractive index, which yields a higher sub-bandgap
 198 reflectance than even PERC cells [27]. Also included in the out-
 199 door tests are mini-modules with commercial Al-BSF and PERC
 200 cells. The three modules were exposed over 75 days to a wide
 201 range of irradiance and ambient conditions, representative of
 202 real, energy-generating environments. The module performance
 203 and meteorological conditions were measured throughout the
 204 test period and used as inputs in a previously developed thermal
 205 model to calculate systematic differences in thermal behavior
 206 attributable exclusively to differences in module reflectance
 207 [28].

208 II. METHODS

209 A. Module Fabrication, Characterization, and Outdoor 210 Installation

211 This test used M2-sized (156.75×156.75 mm) Al-BSF,
 212 PERC, and modified n-PERT solar cells. Schematics of each of
 213 these cells are shown in Fig. 1. The Al-BSF cells were obtained
 214 from a commercial vendor; the PERC and PERT (BiSoN) cells
 215 were from ISC Konstanz. No modifications were performed
 216 on the Al-BSF and PERC cells before incorporating them into
 217 modules.

218 The as-received bifacial PERT cells, however, were aug-
 219 mented with a dielectric/Ag reflector stack on the rear side,
 220 thereby converting the cells into monofacial and allowing a
 221 straightforward comparison to the (also monofacial) Al-BSF
 222 and PERC. Here, silicon dioxide (SiO_2) NP films with a porosity
 223 of approximately 55%—corresponding to a refractive index of
 224 1.2—an average pore size below 10 nm, and a thickness of
 225 at least 300 nm were deposited on the rear side of the PERT
 226 cells via aerosol impact-driven assembly [29]. Silicon- and
 227 oxygen-containing precursors were used to synthesize stoichi-
 228 ometric SiO_2 NPs with average particle size of approximately
 229 5 nm, which were accelerated from the synthesis chamber to
 230 the substrate by a controlled pressure gradient. This method
 231 has previously been used to deposit low-refractive-index porous
 232 Si NPs as a rear reflector layer for silicon heterojunction cells
 233 [30]. The SiO_2 NP synthesis process used here enables lower
 234 refractive index films than our previously studied Si NPs. Fur-
 235 ther descriptions of the deposition and film characterization
 236 processes can be found in prior work [27].

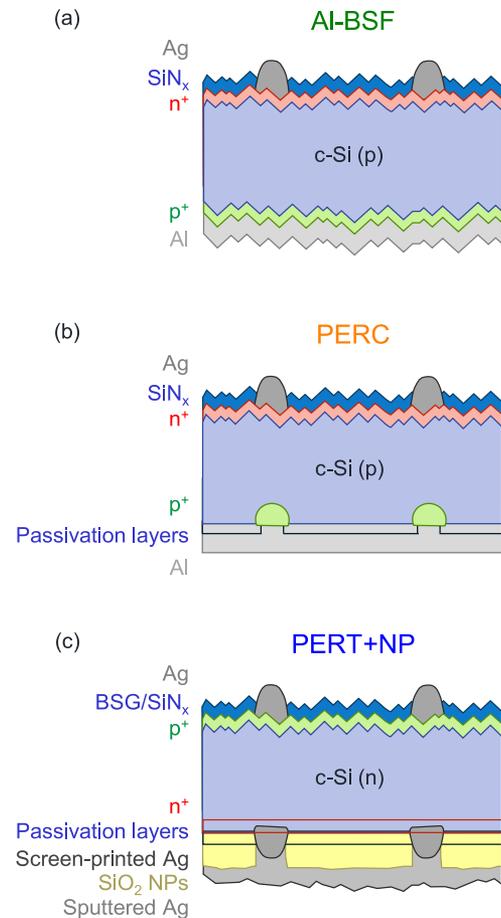


Fig. 1. Schematics of (a) Al-BSF, (b) PERC, and (c) PERT+NP cells used in the mini-modules in this article.

237 During the deposition of the SiO_2 NPs on the rear of the
 238 PERT cells, the silver busbars were covered with a shadow
 239 mask to maintain the electrical contact already established by
 240 the rear-side screen-printed Ag grid. Sputtered Ag layers were
 241 then deposited on the full area of the rear side, per Fig. 1(c), using
 242 an MRC 944 tool with a dc source power of 1 kW. Hereafter, we
 243 call these cells “PERT+NP.” This processing sequence is not
 244 industrially compatible, but was the most expedient and practical
 245 approach for the demonstration sought here, as prior tests
 246 integrating the porous SiO_2 NP film directly into an established
 247 PERC fabrication sequence yielded no optical benefit due to the
 248 fire-through paste reacting with the NP film [27].

249 Another set of PERT cells were converted into monofacial
 250 but did not include the SiO_2 NP film. Instead, Al was sputtered
 251 on the full area of these as-received cells to serve as optical
 252 references. These cells, referred to as “PERT no NP reference,”
 253 were not converted into modules. External quantum efficiency
 254 (EQE) and reflectance spectra of each set of cells were mea-
 255 sured from 300 to 2500 nm using a PV Measurements QEX10
 256 tool and a PerkinElmer Lambda 950 spectrophotometer. These
 257 measurements were used to find active-area, AM1.5G-weighted

258 R for each cell. After cell characterization, the Al-BSF, PERC,
259 and PERT+NP cell batches were packaged into modules.

260 Each module contained nine M2-sized cells. The cells were
261 electrically connected in series and arranged in a closely spaced
262 3×3 grid. The cells were packaged with conventional PV mod-
263 ule materials: textured low-iron cover glass (no antireflection
264 coating), ethyl vinyl acetate (EVA) encapsulant, and a polyvinyl
265 fluoride (PVF)/polyethylene terephthalate/PVF backsheets. Each
266 module used a pair of small, single-pole junction boxes, placed
267 entirely in the margin area away from the cells. Electrolumines-
268 cence imaging after module packaging was performed to ensure
269 that interconnection and lamination had been completed without
270 major damage to the cells. The Al-BSF, PERC, and PERT+NP
271 modules had STC aperture efficiency values of 17.7%, 18.3%,
272 and 18.5%, respectively. Module reflectance and EQE were
273 measured using a Lambda 1050 and NREL's filter EQE system
274 described in prior work [31].

275 We deployed the modules at NREL's outdoor test facility in
276 Golden, Colorado for 75 days. They were oriented to the south
277 at 40° tilt above horizontal. Current–voltage (I – V) curves were
278 collected every 5 minutes and the modules were held at their
279 maximum power points between measurements. In addition to
280 I – V data, simultaneous measurements of ambient tempera-
281 ture (T_{ambient}), wind speed (v_w), and plane-of-array irradiance
282 (E_{POA}) were also collected.

283 Module temperature (T_{module}) was derived from the I – V
284 bilinear interpolation method [32]. Indoor pulse I – V sweeps of
285 each module were performed at each combination of device
286 temperature (15, 20, 25, 30, 35, 40, 45, 50, 55, and 60°C)
287 and irradiance (200, 400, 600, 800, and $1000 \text{ W}\cdot\text{m}^{-2}$). Sixteen
288 thermistors were placed on the back of each module for tempera-
289 ture measurement. Module temperature was uniform to within
290 $\pm 2.25^\circ\text{C}$. Once thermal uniformity was established, the I – V
291 curve was recorded and associated with single-point temperature
292 measurement in the center of the module, made with a resistance
293 temperature detector. The open-circuit voltage (V_{oc}) and I_{sc}
294 from the outdoor I – V sweeps were plugged into an interpolation
295 grid containing 50 grid points from the temperature-controlled,
296 indoor I – V sweeps, to extract T_{module} . This method has been
297 shown to have good accuracy for measuring module temperature
298 [33]. Systematic errors are assumed to affect each of the module
299 types in the same way and are thus neglected to compare relative
300 operating temperatures outdoors.

301 B. Outdoor Data Analysis

302 To assess differences in temperature caused by the differences
303 in sub-bandgap reflectance between each module, a correction
304 factor is applied to the measured data. This correction procedure
305 eliminates temperature variation arising from the other major
306 contributors of temperature variation: irradiance, wind, and
307 module efficiency. The correction factor f is defined as

$$\begin{aligned} f &= f_{\text{irradiance}} \times f_{\text{wind}} \times f_{\text{efficiency}} \\ &= \frac{E_{\text{POA}}^{(\text{ref})}}{E_{\text{POA}}^{(\text{meas})}} \times \frac{c(v_w^{(\text{ref})})}{c(v_w^{(\text{meas})})} \times \frac{1 - \eta_{\text{STC}}^{(\text{ref})}}{1 - \eta_{\text{STC}}^{(\text{meas})}} \end{aligned} \quad (1)$$

TABLE I
CORRECTION FACTOR VARIABLES AND REFERENCE VALUES

Symbol	Quantity	Reference value
E_{POA}	plane-of-array irradiance	$1000 \text{ W}\cdot\text{m}^{-2}$
v_w	wind speed	$1.43 \text{ m}\cdot\text{s}^{-1}$
$c(v_w)$	lumped heat transfer factor	0.0256
η_{STC}	STC efficiency	17.7%

where E_{POA} is plane-of-array irradiance, $c(v_w)$ is the wind-
dependent heat-transfer factor, and η_{STC} is STC efficiency. The
lumped heat-transfer factor used here is an empirically derived
function of wind speed, the dominant heat transfer mechanism
in fielded modules [34]. Its derivation method is detailed in
prior work [35]. The full derivation of the correction term f is
also described in detail in prior work [28]. Measured values
are represented with superscript (meas) and reference values
with superscript (ref). The reference ambient conditions and
reference module properties used in this experiment are shown
in Table I. These values were chosen to minimize the average
magnitude of the correction and to be representative of the most
relevant energy-generating conditions.

The raw temperature rise above ambient ΔT^{raw} is

$$\Delta T^{\text{raw}} = T_{\text{module}}^{(\text{meas})} - T_{\text{ambient}}^{(\text{meas})} \quad (2)$$

The correction factor based on the reference values is applied
to the measured values for each module to calculate the corrected
temperature rise above ambient ΔT as follows:

$$\Delta T = \Delta T^{\text{raw}} \times f. \quad (3)$$

The corrected temperature rise ΔT represents what the mod-
ule temperature rise above ambient *would have been* if the
module under test had the reference properties and had been
measured under the reference conditions [28]. As the correction
factor eliminates temperature differences from other major fac-
tors, differences in ΔT between modules are caused exclusively
by differences in reflectance. That is, two modules with the same
reflectance will have the same ΔT , even if they have different
efficiencies or were measured with different irradiances and
wind speeds. The ΔT values of each module throughout the
75-day test period are used to facilitate comparisons between
the modules, which have different reflectances.

To minimize deviation from the steady-state energy balance
between the module under test and the ambient—the basis of the
thermal model—data were removed at instances with apprecia-
ble snow, large changes in irradiance, or large changes in wind
speed. For irradiance, the data were removed if the difference
between the maximum and minimum measured values was
greater than $3 \text{ W}\cdot\text{m}^{-2}$ for 30 s before and after the measurement.
For wind speed, the data were filtered if the difference between
the maximum and minimum measured values was greater than 5
 $\text{m}\cdot\text{s}^{-1}$ for the 12 minutes before the measurement. The presence
of snow was detected by comparing the predicted I_{sc} of the
module to the measured I_{sc} . The predicted I_{sc} is defined as the
median I_{sc} between 950 – $1050 \text{ W}\cdot\text{m}^{-2}$ multiplied by the quantity

350 (measured $I_{sc} / 1000 \text{ W} \cdot \text{m}^{-2}$). The data were removed if the ratio
 351 of the measured I_{sc} to the predicted I_{sc} was not between 0.85
 352 and 1.15.

353 III. RESULTS AND DISCUSSION

354 A. Sample Characterization

355 The reflectance of the cells before module packaging is shown
 356 in Fig. 2(a). As the front Ag fingers of the completed cells
 357 fell within the aperture of the reflectance measurements, the re-
 358 flectance data were corrected to represent active-area reflectance
 359 by dividing by the unmetallized areal fraction. The reflectance
 360 at 1200 nm approaches 55% for the PERT+NP cells—the best
 361 ever demonstrated for a PERT or PERC cell, to the authors’
 362 knowledge. The PERT+NP had higher reflectance than the
 363 PERT reference with full-area Al metallization, revealing the
 364 effectiveness of the SiO_2 NP film/Ag rear reflector stack. Ad-
 365 ditionally, the PERT+NP reflectance was higher than by the
 366 Al-BSF and PERC cells. The reason the PERT+NP cells do not
 367 reach the over 90% reflectance seen in prior work is infrared
 368 parasitic absorption occurring in heavily doped regions besides
 369 the rear reflector.

370 EQE and $1-R$ for the fully fabricated modules are shown in
 371 Fig. 2(b), with AM1.5G-weighted R values shown in parenthe-
 372 ses. The module materials impart parasitic absorption and reduce
 373 the reflectance benefit of the rear reflector. R at 1200 nm for
 374 the PERT+NP cell was 54.5% and dropped by 17.3% absolute to
 375 37.2% after module packaging. For PERC and Al-BSF, this drop
 376 after module packaging was 12.1% and 2.1%, respectively. The
 377 reduction in R is attributable to parasitic absorption by the glass
 378 and to a larger degree by the EVA, which has several character-
 379 istic absorption peaks visible in Fig. 2(b). Similarly, Vogt *et al.* [26]
 380 calculated $38.0 \text{ W} \cdot \text{m}^{-2}$ and $43.7 \text{ W} \cdot \text{m}^{-2}$ of parasitic absorption
 381 in the glass and EVA layers for Al-BSF and PERC modules,
 382 respectively, in the 1210–2500 nm spectral range. Haedrich
 383 *et al.* calculated the annual energy loss of a PERC module to be
 384 4.4% due to module embedding, primarily from front cover glass
 385 reflectance and also parasitic absorption in the module glass and
 386 EVA [3]. Higher reflectance also contributes to improved EQE
 387 in the 1000–1200 nm wavelength range because this light gets
 388 a longer path length through the silicon.

389 The impact of parasitic absorption by the module materials in
 390 the super- and sub-bandgap ranges for the devices tested here can
 391 be seen in Fig. 2(c). Super-bandgap (250–1100 nm) reflectance is
 392 undesirable. While it does reduce module operating temperature,
 393 it also reduces I_{sc} and should thus be avoided. The most desirable
 394 outcome is to minimize the purple bars and maximize the red
 395 bars (though the red bars will not exceed 19%). The AM1.5G-
 396 weighted reflectance for the PERT+NP module was 11.2%,
 397 6.3% of which was in the 250–1100 nm range. This reveals that,
 398 of the approximately 19% sub-bandgap light, the PERT+NP
 399 module rejected just 4.9%, even though optimized test structures
 400 demonstrated a path to 90% reflectance at 1200 nm. The differ-
 401 ence in sub-bandgap AM1.5G-weighted R (red bars) between
 402 cell and module for Al-BSF, PERC, and PERT+NP is 0.93,
 403 2.59, and 3.14% absolute, respectively. This shows that the
 404 superior sub-bandgap reflectance of the PERT+NP cell does

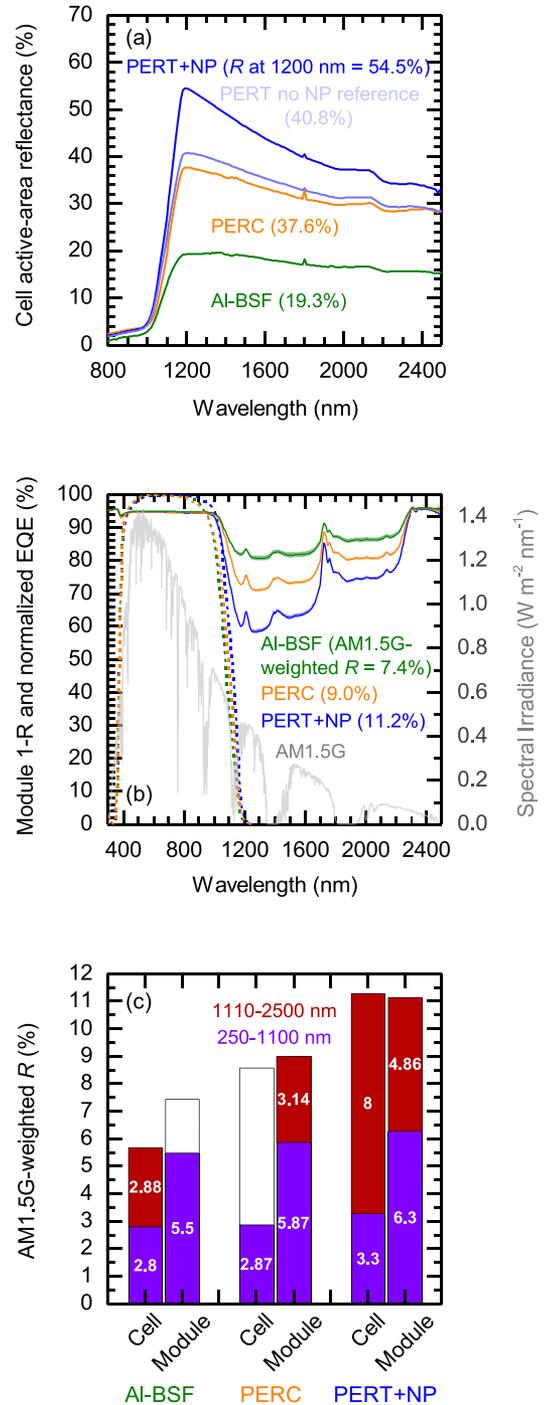


Fig. 2. Plot of (a) active-area R for each cell, (b) $1-R$ and normalized EQE for the fully fabricated modules, and (c) AM1.5G-weighted R for each cell and module. The full height is the reflection from 250–2500 nm, with sub-bands as indicated.

not entirely carry over after module packaging, revealing that improvements in sub-bandgap reflectance at the rear side must be in coordination with the optical properties of the fully fabricated module to capture the full thermal benefit.

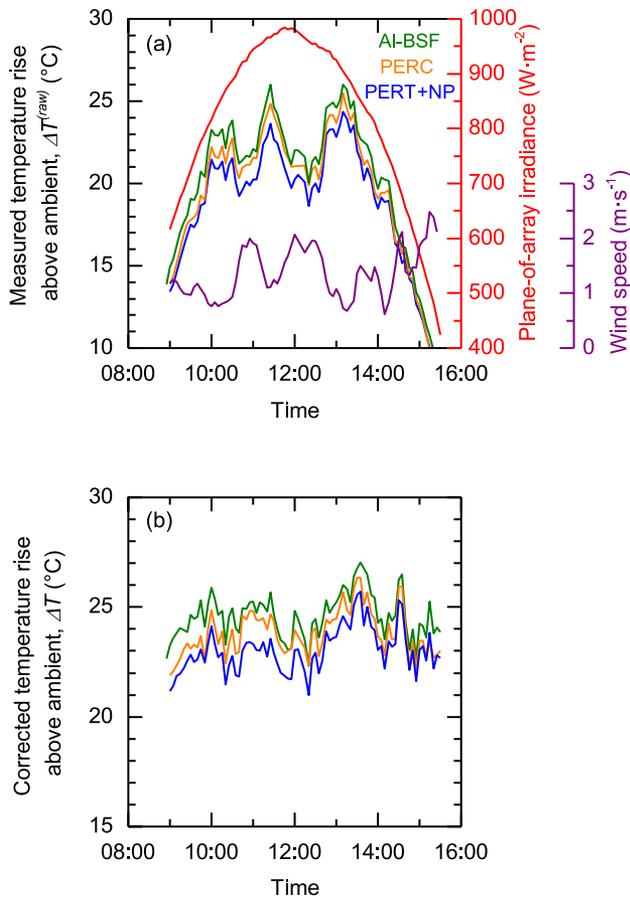


Fig. 3. (a) Measured module temperature rise above ambient and irradiance for one day in the test period (December 9th). (b) Corrected module temperature rise above ambient from the same day.

409 B. Outdoor Data

410 Fig. 3(a) shows ΔT^{raw} with corresponding irradiance and
 411 wind speed data from one day in the test range where nearly
 412 all data met the steady-state energy balance requirements. Since
 413 each set of module data is from the same moment, the differences
 414 between ΔT^{raw} values are not due to meteorological factors, but
 415 rather only from the differences in module performance (efficiency
 416 and reflectance). Systematic temperature differences on
 417 this day are revealed by the raw data: PERT+NP runs cooler than
 418 PERC, which in turn runs cooler than Al-BSF. As expected, in a
 419 given day with large irradiance changes, relatively large changes
 420 in module operating temperature are also observed. Note that
 421 the module temperature does not follow the irradiance precisely
 422 because of the variable wind speed: the approximately 1 m·s⁻¹
 423 increases in wind speed at 10:30 and 12:00 reduce the temper-
 424 ature by several degrees. Fig. 3(b) shows the corresponding
 425 ΔT for this same day, which collapses the data around a tighter
 426 distribution of temperature values. As a reminder, ΔT are the
 427 module temperature rise above ambient that the modules would
 428 have experienced if they all shared the performance characteris-
 429 tics and measurement conditions in Table I. The corrected data
 430 similarly show a systematic difference in ΔT between modules,

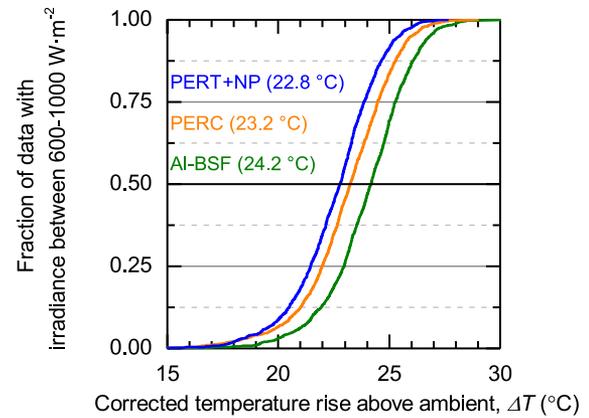


Fig. 4. Corrected temperature rise above ambient for each tested module displayed as a cumulative distribution function (CDF). The median values for each tested module are shown in parentheses.

which in this corrected case, is due just to reflectance as the
 correction accounts for differences in efficiency.

431
 432
 433 Fig. 4 plots ΔT for each module, in the 600–1000 W·m⁻²
 434 irradiance range, as a cumulative distribution function (CDF).
 435 The median ΔT value occurs when the CDF equals 0.5; each
 436 module operates warmer than its median value for half of the
 437 time and cooler than this value for the other half of the time.
 438 For the Al-BSF, PERC, and PERT+NP modules, the median ΔT
 439 value was 24.2, 23.2, and 22.8 °C, respectively. The difference
 440 between these median values is a good metric into which all
 441 of the data can be consolidated to yield a single temperature
 442 benefit value attributable to reflectance. At the chosen reference
 443 conditions (1000 W·m⁻², 1.43 m·s⁻¹, and 25 °C), the PERC
 444 module operates 1.0 °C cooler than Al-BSF, and the PERT+NP
 445 module operates 1.4 °C cooler than Al-BSF and 0.4 °C cooler
 446 than PERC. For a module with a temperature coefficient of
 447 $-0.4\%/^{\circ}\text{C}$, 1.4, and 0.4 °C temperature decreases result in 0.56
 448 and 0.16% absolute gains in efficiency, respectively. The statisti-
 449 cal significance of these median differences is validated with
 450 Mann–Whitney U tests: the medians are statistically different at
 451 over a 0.01 level (Z scores of 7.9, 12.7, and 20.2, respectively).
 452 Thus, there is a clear and systematic difference in operating
 453 temperature attributable to the sub-bandgap reflectance of each
 454 module. The 1.0 °C temperature benefit of PERC relative to
 455 BSF from reflectance measured here is consistent with the
 456 0.9 °C calculated by Vogt *et al.* [26] for the same 1000 W·m⁻²
 457 irradiance.

458 In evaluating the relative thermal performance of one cell
 459 design against others, it is instructive to compare the temper-
 460 atures of pairs of modules. Fig. 5 shows differences between
 461 module temperatures taken at the same time and corrected just
 462 for efficiency, making the temperature differences due solely to
 463 reflectance. The data are binned according to irradiance and the
 464 total plotted range of 600–1000 W·m⁻² accounts for approxi-
 465 mately 86% of the power production for the Al-BSF module
 466 in this article. The mean temperature benefit of the PERT+NP
 467 module over the Al-BSF and PERC modules increases at higher
 468 irradiances, revealing that this thermal management approach has

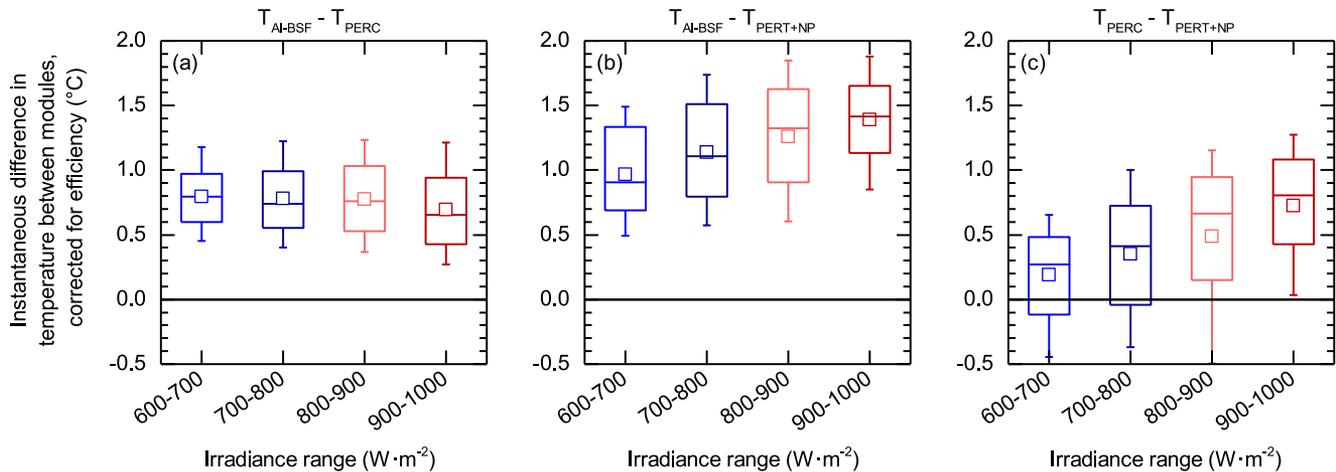


Fig. 5. Temperature difference between (a) Al-BSF and PERC, (b) Al-BSF and PERT+NP, and (c) PERC and PERT+NP modules displayed as boxes and whiskers and binned by irradiance. Boxes represent 25–75 percentiles, whiskers represent 10–90 percentiles, and inset boxes and lines represent mean and median values, respectively.

469 the largest impact at the most important conditions: high irradiance and, consequently, high power generation. The Al-BSF
 470 and PERC comparison, surprisingly, does not show this same irradiance dependence. We hypothesize that this may be due to
 471 noise from the indoor interpolation method related to spectral mismatch between the Xenon flash lamp and typical outdoor
 472 irradiance. We hypothesize that this may be due to noise from the indoor interpolation method related to spectral mismatch between the Xenon flash lamp and typical outdoor
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476 IV. CONCLUSION

477 Fielded modules can benefit from the thermal management strategy of rejecting unusable sub-bandgap light, thereby improving lifetime energy production. Here, we found that adding an optimized rear-reflector stack provides a temperature benefit of 1.4 and 0.4°C over fielded Al-BSF and PERC modules, respectively. Importantly, we found that the rear SiO₂ NP/Ag reflector is most effective during periods of highest irradiance, when power generation is highest. To capture the full temperature benefit of approximately 2.8°C associated with this approach, parasitically absorbing materials such as module glass and EVA should be replaced with low-infrared-absorbing alternatives, and heavily-doped regions in the cell should be strategically localized.

489 The technique used here to implement the reflector technology—converting a bifacial cell to monofacial—is not suitable for industrial application. In a previous study, we found the porous SiO₂ film to be chemically incompatible with the etching mechanism of fire-through Al pastes. However, this limitation is not insurmountable. Just as traditional Al-BSF paste chemistries were modified to prevent damage to the SiN_x passivation layers in PERC cells, additional paste optimization could enable an optimized optical film that complements the dielectric passivation stack [36]. Similarly, making pastes less damaging is an active area of research for polysilicon contacts [37]. Integrating low-refractive-index dielectric layers with more gentle paste chemistries could be a worthwhile cell development effort, especially in cases where bifaciality is irrelevant and thermal management via sub-bandgap reflectance is particularly important.

500 Such cases include residential and commercial rooftop systems, where conductive/convective cooling of modules is reduced or completely suppressed and higher module temperatures create higher building cooling loads in summer [15]. Furthermore, such dedicated optical films can be integrated into solar cells with full-area passivating contacts, such as polysilicon or silicon heterojunction. Augmenting the superior electrical performance of passivating contacts with the additional optical-thermal benefit from an optimized sub-bandgap reflector could further enhance their applicability in the PV module market.

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